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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/717,406	11/19/2003	Charles Q. Zhan	120 06741US	7240
128	7590	05/05/2005		EXAMINER LE, TOAN M
HONEYWELL INTERNATIONAL INC. 101 COLUMBIA ROAD P O BOX 2245 MORRISTOWN, NJ 07962-2245			ART UNIT 2863	PAPER NUMBER

DATE MAILED: 05/05/2005

Please find below and/or attached an Office communication concerning this application or proceeding.

<b>Office Action Summary</b>	<b>Application No.</b>	<b>Applicant(s)</b>	
	10/717,406	ZHAN ET AL.	
	<b>Examiner</b> Toan M. Le	<b>Art Unit</b> 2863	

-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

#### Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133). Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

#### Status

- 1) Responsive to communication(s) filed on 14 February 2005.
- 2a) This action is FINAL.                            2b) This action is non-final.
- 3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

#### Disposition of Claims

- 4) Claim(s) 1-22 is/are pending in the application.
  - 4a) Of the above claim(s) \_\_\_\_\_ is/are withdrawn from consideration.
- 5) Claim(s) 21 and 22 is/are allowed.
- 6) Claim(s) 1,2,4,5,7-9,11,14-16 and 18 is/are rejected.
- 7) Claim(s) 3,6,10,12,13,17,19 and 20 is/are objected to.
- 8) Claim(s) \_\_\_\_\_ are subject to restriction and/or election requirement.

#### Application Papers

- 9) The specification is objected to by the Examiner.
- 10) The drawing(s) filed on 19 November 2003 is/are: a) accepted or b) objected to by the Examiner.
 

Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).

Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).
- 11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.

#### Priority under 35 U.S.C. § 119

- 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
    - a) All    b) Some \* c) None of:
      1. Certified copies of the priority documents have been received.
      2. Certified copies of the priority documents have been received in Application No. \_\_\_\_\_.
      3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- \* See the attached detailed Office action for a list of the certified copies not received.

#### Attachment(s)

- |  |   |
|--|---|
| 1) <input checked="" type="checkbox"/> Notice of References Cited (PTO-892)  | 4) <input type="checkbox"/> Interview Summary (PTO-413)                     |
| 2) <input type="checkbox"/> Notice of Draftsperson's Patent Drawing Review (PTO-948)   | Paper No(s)/Mail Date. _____.   |
| 3) <input checked="" type="checkbox"/> Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08)<br>Paper No(s)/Mail Date <u>2/14/05</u> . | 5) <input type="checkbox"/> Notice of Informal Patent Application (PTO-152) |
|  | 6) <input type="checkbox"/> Other: _____.                                   |

**DETAILED ACTION**

***Claim Rejections - 35 USC § 102***

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless –

(a) the invention was known or used by others in this country, or patented or described in a printed publication in this or a foreign country, before the invention thereof by the applicant for a patent.

Claims 1-2, 4-5, 7-9, 11, 14-16, and 18 are rejected under 35 U.S.C. 102(a) as being anticipated by “Applying MultiResolution Analysis for Processing of Hydraulic Pump Fault Signal”, Wanlu et al. (referred hereafter Wanlu et al.).

Referring to claims 1, 8, and 15, Wanlu et al. disclose a method; apparatus; a computer program embodied on a computer readable medium and operable to be executed by a processor, the computer program comprising computer readable program code (Abstract); comprising:

decomposing a signal comprising a plurality of process variable measurements into a plurality of resolution levels, the process variable measurements associated with operation of a valve (page 2, 2<sup>nd</sup> col., lines 19-37; equations 11-17; figure 1);

grouping the resolution levels into a plurality of groups (page 2, 2<sup>nd</sup> col., lines 19-37; equations 11-17); and

identifying one or more defect indicators for at least some of the resolution levels using the groups, the one or more defect indicators associated with a possible defect in the valve (page 4, 1<sup>st</sup> col., 2<sup>nd</sup> paragraph and last paragraph to page 4, 2<sup>nd</sup> col., 1<sup>st</sup> and last paragraphs; figure 2).

As to claims 2, 9, and 16, Wanlu et al. disclose a method; apparatus; a computer program embodied on a computer readable medium and operable to be executed by a processor, the computer program comprising computer readable program code, wherein:

decomposing the signal comprises performing wavelet decomposition to generate wavelet coefficients at each of the resolution levels (page 2, 2<sup>nd</sup> col., lines 19-37; page 3, 2<sup>nd</sup> col., last paragraph; table 1);

grouping the resolution levels comprises grouping the wavelet coefficients into groups (page 2, 2<sup>nd</sup> col., lines 19-37; equations 11-17); and

identifying the one or more defect indicators comprises performing singularity detection using the groups of wavelet coefficients (page 4, 1<sup>st</sup> col., 2<sup>nd</sup> paragraph and last paragraph to page 4, 2<sup>nd</sup> col., 1<sup>st</sup> and last paragraphs; figure 2).

Referring to claims 4, 11, and 18, Wanlu et al. disclose a method; apparatus; a computer program embodied on a computer readable medium and operable to be executed by a processor, the computer program comprising computer readable program code, wherein the one or more defect indicators identify one or more jumps in the process variable measurements (page 4, 2<sup>nd</sup> col., last paragraph; figure 2).

As to claim 5, Wanlu et al. disclose a method, wherein the one or more jumps represent one or more deterministic signal changes where the process variable measurements change by a threshold amount within a given time period (page 4, 2<sup>nd</sup> col., last paragraph; figure 2).

Referring to claims 7 and 14, Wanlu et al. disclose a method; apparatus; a computer program embodied on a computer readable medium and operable to be executed by a processor, the computer program comprising computer readable program code, wherein grouping the

resolution levels into the plurality of groups comprises grouping the adjacent three resolution levels into groups, the groups forming overlapping groups where at least some of the resolution levels form part of two or more groups (page 2, 2<sup>nd</sup> col., lines 19-37; equations 11-17; page 4, 2<sup>nd</sup> col., 1<sup>st</sup> paragraph; figure 2).

Claims 3, 6, 10, 12-13, 17, 19-20 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

The reason for allowance of the claims 3, 6, 10, 12-13, 17, 19-20 is the inclusion of steps of determining a probability of a valve defect based on the selected resolution level from measurements of a flow rate through the valve and generating a second signal for a valve adjuster.

Wanlu et al. neither teach nor suggest those limitations.

***Allowable Subject Matter***

Claims 21-22 are allowed.

The reason for allowance for the claims 21-22 is the inclusion of a controller operable to generate output values for adjusting the valve based on the process variable measurements associated with the operation of the valve.

Wanlu et al. neither teach nor suggest this feature.

**Remarks:**

***Response to Arguments***

Applicant's arguments filed 2/14/05 have been fully considered but they are not persuasive.

Referring to claims 1, 8, and 15, Applicant argues that “Wanlu lacks any mention of grouping decomposition layers into multiple groups and then identifying defect indicators using the multiple groups.”

Wanlu discloses “According to the multi-resolution analysis [4], there is a set of recurrence decomposition formulas for the signal  $f(t)$  as follows, equations 11-17. Where  $A_j f(t)$  is the low-frequency approximation of  $f(t) \in L^2(\mathbb{R})$  on the scale  $2^j$ .  $D_j f(t)$  is the high-frequency detail of  $f(t) \in L^2(\mathbb{R})$  on the scale  $2^j$ . The coefficient sequence  $\{h_n; n \in \mathbb{Z}\}$  is the low-pass filter coefficients corresponding to the scaling function  $\phi(t)$ . The coefficient sequence  $\{g_n; n \in \mathbb{Z}\}$  is the high-pass filter coefficients corresponding to the wavelet function  $\psi(t)$ . The two coefficient sequences constitute the orthogonal conjugate filters.” on page 2, 2<sup>nd</sup> col., lines 19-37. And “The characteristic frequency of the shoe-loosing fault is equal to the rotational frequency. When we conduct the threshold noise elimination to d1d2d3, the frequency band of the noise elimination is 0.625~5kHz, the ultra-harmonics of the fault characteristic signal loses a little.” on page 4, 1<sup>st</sup> col., 2<sup>nd</sup> paragraph.

Thus, Wanlu does disclose grouping decomposition layers into multiple groups in the sum of  $A_j f(t)$  for low frequency approximation and in the sum of  $D_j f(t)$  for high frequency and then identifying defect indicators using the multiple groups.

### ***Conclusion***

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Toan M Le whose telephone number is (571) 272-2276. The examiner can normally be reached on Monday through Friday from 9:00 A.M. to 5:30 P.M..

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John Barlow can be reached on (571) 272-2269. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Toan Le

April 20, 2005



John Barlow  
Supervisory Patent Examiner  
Technology Center 2800